

EMC TEST REPORT

REPORT NO. : <u>CE88030401</u>

MODEL NO. : <u>PCM-4896</u>

DATE OF TEST: March 04 ~ 08, 1999

PREPARED FOR: <u>AAEON TECHNOLOGY INC.</u>

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1. **CERTIFICATION**

Issue date: March 09, 1999

Product **CPU BOARD**

Trade Name : AAEON Model No. PCM-4896

Applicant : AAEON TECHNOLOGY INC.

Standard EN 55022:1994+A1:1995+A2:1997, EN 50082-2:1995

> Class A EN 61000-4:2:1995

EN 61000-4-3:1996 EN 61000-4-4:1995 EN 61000-4-6:1996 EN 61000-4-8:1994 ENV 50204:1996

We hereby certify that one sample of the designation has been tested in our facility from March 04 to 08, 1999. The test record, data evaluation and Equipment Under Test (EUT) configurations represent herein are true and accurate representation of the measurements of the sample's EMC characteristics under the conditions herein specified.

TESTED BY (Emission) : A | an Chang (Alan Chang), DATE: $6 \frac{1}{2} / \frac{09}{99}$ (TESTED BY (Immunity) (S. S. Wang), DATE: $\frac{03}{99} / \frac{99}{99}$

(Immunity)

CHECKED BY: (Yemmy Soong)

APPROVED BY: Soong, DATE: 3/9/99

(Mike Su)

ADVANCE DATA TECHNOLOGY CORPORATION

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2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Product : CPU BOARD Model No. : PCM-4896

Power Supply Type : Switching, DC (from PC)

Data Cable : N/A

Note: During the test, the EUT was installed in a metal enclosure with a slot board to form an industrial PC. The Industrial PC includes the following:

* Chassis : AAEON, model: AIPC-110

* Switching power supply: EMACS, model: AX2-5250F

* FDD : MITSUMI, model: D353M3 * HDD : QUANTUM, 3.5 Series

* CPU : CYRIX MEDIA-GX 200 MHz

The EUT was tested under the CPU: 200 MHz, frequency of clock generator is 66.6 MHz and has a resolution up to 1024x768.

For more detailed features description, please refer to Manufacturer's Specification or User's Manual.

2.2 GENERAL DESCRIPTION OF APPLIED STANDARD

The EUT is a kind of Information Technology Equipment which could be used in industrial area and according to the manufacturer's specifications, it was tested according to the following standards:

EN 55022:1994+A1:1995+A2:1997, Class A EN 50082-2:1995

EN 61000-4-2:1995 EN 61000-4-3:1996 EN 61000-4-4:1995 EN 61000-4-6:1996 EN 61000-4-8:1994 ENV 50204:1996

REPORT NO.: CE88030401

All tests are performed and recorded as per above standards.



2.3 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories are used to form representative test configuration during the tests.

FOR EMISSION TEST

No	Product	Brand	Model No.	Serial No.	I/O Cable	
1	COLOR		DD 050	M500222452	Shielded Signal (1.5m)	
1	MONITOR	ADI	PD-959	M500233452	Nonshielded Power (1.8m)	
2	DDINTED	IID	22250	2026556204	Shielded Signal (1.4m)	
2	PRINTER	HP	2225C+	2936S56294	Nonshielded Power (1.2m)	
	MODEM 4	ACCEV	1 4 1 4	IEAVDM1414	Shielded signal (1.2m)	
3	MODEM x4	ACEEX	1414	IFAXDM1414	Nonshielded Power (1.2m)	
4	KEYBOARD	FORWARD	FDA-104GA	F4ZDA-104G	Shielded Signal (1.4m)	
5	MOUSE	DEXIN	A2P800A	NIYA2P800A	Shielded signal (1.5m)	
	USB	DEC	BTC 7932	EZWINDLICD10410	G1: 11 1G: 1/17)	
6	KEYBOARD	BIC		E5XKBUCP10410	Shielded Signal (1.5m)	
7	USB MOUSE	DEXIN	A2U800A	NIYA2U800A	Shielded Signal (1.5m)	
0	DC.	IDM	6560 TTT	0002700	Nonshielded power (1.8m)	
8	PC	IBM	6560-T7T	9983708	Shielded Signal (1.8m)	
	MONUTOR	A CED	7124T	N/500022452	Shielded signal (1.3m)	
9	MONITOR	ACER	7134T	M500233452	Nonshielded power (1.8m)	
10	KEYBOARD	FORWARD	FDA-104GA	FDKB8110129	Nonshielded signal (1.4m)	
11	MOUSE	DEXIN	A2P800A	80110021	Shielded signal (1.5m)	
12	LAN CARD	INTEL	S82555	00A0C9A6CB525271	NA	

Note: Support unit 1~7 acted as SERVER PC and communicated with support unit 8-12 which acted as HOST PC and systems of communication partner via a UTP cable (10m).



FOR IMMUNITY TEST

No	Product	Brand	Model No.	Serial No.	I/O Cable
1	COLOR	ACER	7024-	0174202002	Shielded Signal (1.5m)
1	MONITOR	ACEK	7234e	9174302003	Nonshielded Power (1.8m)
2	PRINTER	HP	C2145A	SG5BN160GY	Shielded Signal (1.5m)
	FRINTER	пг	C2143A	3G3BN100G1	Nonshielded Power (1.8m)
			F-1128V1R6	96-191-113003	
3	MODEM 4	GVC	F-1128V1R6	96-191-113004	Shielded signal (1.25m)
3	MODEM X4	IODEM x4 F-1114V1R6 853E100		853E100	Nonshielded Power (1.5m)
		ACEEX	1414	980020528	
4	KEYBOARD	ACER	6311	K6355122516	Shielded Signal (1.8m)
5	MOUSE	COMPAQ	13H6690	23-D365100	Shielded signal (1.8m)
6	USB	ВТС	7932	D7A140018	Shielded Signal (1.8m)
	KEYBOARD				
7	USB MOUSE	DEXIN	A2U800A	71001830	Shielded Signal (1.5m)
8	PC	NTI	PII-233	P201097	Nonshielded power (1.8m)
0	10	1111	111-233	1201077	Shielded Signal (1.8m)
9	MONITOR	ADI	PV-448	604012V00100231A	Shielded signal (1.5m)
9	MONTOR	ADI	Г V - 44 0	004012 V 00100231A	Nonshielded power (1.8m)
10	KEYBOARD	HP	C3758A	K101088	Nonshielded signal (1.8m)
11	MOUSE	HP	M-S34	LZA72701223	Shielded signal (1.8m)
12	LAN CARD	3 COM	3C905B-TX	6NKD0BEFCB	NA

Note: Support unit 1~7 acted as SERVER PC and communicated with support unit 8-12 which acted as HOST PC and systems of communication partner via a UTP cable (10m).

2.4 TEST SETUP

Please refer to the photos of test configuration in Item 6.



3. TEST INSTRUMENTS

3.1 TEST INSTRUMENTS (EMISSION)

CONDUCTED EMISSION MEASUREMENT

Description & Manufacturer	Model No.	Serial No.	Calibrated Until
ROHDE & SCHWARZ Test	ESHS30	828109/007	July 22, 1999
Receiver	2511550	0201037007	vary 22, 1999
ROHDE & SCHWARZ	ESH2-Z5	892107/003	July 20, 1000
Artificial Mains Network	ESHZ-ZS	892107/003	July 20, 1999
EMCO L.I.S.N.	3825/2	9504-2359	July 20, 1999
Shielded Room	Site 3	ADT-C03	N/A

Note: 1. The measurement uncertainty is less than +/- 2.6dB, which is calculated as per NAMA's document NIS81.

2. The calibration interval of the above test instruments is 12 months.

And the calibrations are traceable to NML/ROC and NIST/USA.

RADIATED EMISSION MEASUREMENT

Description & Manufacturer	Model No.	Serial No.	Calibrated Until
HP Spectrum Analyzer	8594E	3520A01861	Feb. 08, 2000
HP Preamplifier	8447D	2944A08118	June 28, 1999
HP Preamplifier	8347A	3307A01088	Sept. 9, 1999
ROHDE & SCHWARZ TEST RECEIVER	ESVS 10	840241/010	Sept. 10, 1999
SCHWARZBECK Tunable	VHA 9103	E101051	Nov. 25, 1000
Dipole Antenna	UHA 9105	E101055	Nov. 25, 1999
CHASE BILOG Antenna	CBL6111A	1079	July 17, 1999
EMCO Double Ridged Guide Antenna	3115	9312-4192	April 3, 1999
CHANCE Turn Table	U200	9701	N/A
CHANCE Tower	AT-100	CM-A003	N/A
Open Field Test Site	Site 3	ADT-R03	July 16, 1999

Note: 1. The measurement uncertainty is less than +/- 3dB, which is calculated as per NAMA's document NIS81.

2. The calibration interval of the above test instruments is 12 months.

And the calibrations are traceable to NML/ROC and NIST/USA.



3.2 TEST INSTRUMENTS (IMMUNITY)

Description & Manufacturer	Model No.	Serial No.	Calibrated Until
KeyTek, ESD Test System	2000	9105240/41	Aug. 9, 1999
KeyTek, ESD Simulator	MZ-15/EC	92022232	April 15, 1999
KeyTek, EFT Generator	CE-40	9508257	Sept. 8, 1999
KeyTek, Capacitive Clamp	CE-40-CCL	9508259	Sept. 9, 1999
KeyTek, Control Center	E103	9508347	N/A
KeyTek, Surge Combination Wave	E501A	9508349	Sept. 3, 1999
KeyTek, Surge Coupler/Decoupler	E551	9508350	Sept. 3, 1999
ROHDE & SCHWARZ Signal Generator	SMY01	840490/009	Sept. 30, 1999
KALMUS Power Amplifier	LA1000V	091995-1	N/A
KALMUS Power Amplifier	757LC	091995-2	N/A
HOLADAY Field Probe	HI-4422	89915	Oct. 27, 1999
EMCO BiconiLog Antenna	3141	1001	N/A
FCC Coupling Decoupling Network	FCC-801-M3-25	48	N/A
FCC Coupling Decoupling Network	FCC-801-M2-25	20	N/A
FCC Coupling Decoupling Network	FCC-801-M1-25	17	N/A
BOONTON RF Voltage Meter	9200B	331801AE	Dec. 17, 1999
COMTEST Compact Full Anechoic Chamber (7x3x3 m)	CFAC	ADT-S01	Aug. 4, 1999
HAEFELY Mains Interference Simulator	PLINE 1610	083690-17	July 6, 1999
HAEFELY Magnetic Field Tester	MAG 100.1	083794-06	N/A
COMBINOVA Magnetic Field Meter	MFM10	224	Aug. 26, 1999

Note: The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.



3.3 LIMITS OF CONDUCTED AND RADIATED EMISSION

LIMIT OF RADIATED EMISSION OF EN 55022

FREQUENCY	Class A (at 10m)	Class B (at 10m)
(MHz)	dBuV/m	dBuV/m
30 - 230	40	30
230 - 1000	47	37

Note: (1) The lower limit shall apply at the transition frequencies.

- (2) Emission level (dBuV/m) = 20 log Emission level (uV/m).
- (3) All emanation from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

LIMIT OF CONDUCTED EMISSION OF EN 55022

FREQUENCY	Class A	(dBuV)	Class B (dBuV)		
(MHz)	Quasi-peak	Average	Quasi-	Average	
			peak		
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

Note: (1) The lower limit shall apply at the transition frequencies.

- (2) The limit decreases linearly with the logarithm of the frequency in the range 0.15 to 0.50~MHz
- (3) All emanation from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.



4. TEST RESULTS (EMISSION)

4.1 RADIO DISTURBANCE

Product Family Standard : EN 55022+A1:1995+A2:1997, Class B Frequency Range : 0.15 - 30 MHz (Conducted Emission)

30 - 1000 MHz (Radiated Emission)

Input Voltage : 230 Vac, 50 Hz (to PC)

Temperature : 25 degree

Humidity : 58 %

Atmospheric Pressure : 1000 mbar

TEST RESULT Remarks					
DACC	Minimum passing margin of conducted emission: -16.4 dB at 0.199 MHz				
PASS	Minimum passing margin of radiated emission: -4.9 dB at 38.98 MHz				

4.2 EUT OPERATION CONDITION

- 1. Turn on the power of all equipments.
- 2. Industrial PC reads a test program to enable all functions.
- 3. Industrial PC reads and writes messages from HDD.
- 4. Industrial PC sends and receives messages to and from WORKSTATION PC via a UTP cable.
- 5. Industrial PC sends "H" messages to monitor and monitor display "H" patterns on screen.
- 6. Industrial PC sends "H" messages to modem.
- 7. Industrial PC sends "H" messages to printer, and the printer prints them on paper.
- 8. Repeat steps 2-8.



4.3 TEST DATA OF CONDUCTED EMISSION

EUT: <u>CPU BOARD</u> MODEL: <u>PCM-4896</u>

6 dB Band Width: 10 kHz

Freq.	Freq. L Level		N L	N Level Limi		nit	t Margin [dB (mV)]			
[MHz]	[dB (1	Ƴ V)]	[dB (mV)]		[dB (mV)]		L		N	
	QP	AV	QP	AV	QP	AV	QP	AV	QP	AV
0.199	62.4	-	62.6	ı	79.0	66.0	-16.6	ı	-16.4	-
0.299	55.1	-	55.3	ı	79.0	66.0	-23.9	ı	-23.7	-
0.495	53.2	-	53.4	ı	79.0	66.0	-25.8	ı	-25.6	-
0.896	43.7	-	43.6	ı	73.0	60.0	-29.3	ı	-29.4	-
5.051	49.3	-	49.0	ı	73.0	60.0	-23.7	ı	-24.0	-
20.203	42.1	-	42.7	-	73.0	60.0	-30.9	-	-30.3	-

Remarks: 1. "*": Undetectable

- 2. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 3. "-": The Quasi-peak reading value also meets average limit and measurement with the average detector is unnecessary.
- 4. The emission level of other frequencies were very low against the limit.
- 5. Margin value = Emission level Limit value



4.4 TEST DATA OF RADIATED EMISSION

EUT: **CPU BOARD** MODEL: **PCM-4896**

ANT. POLARITY: Horizontal

DETECTOR FUNCTION: Quasi-peak 6 dB BANDWIDTH: <u>120</u> kHz

FREQUENCY RANGE: 30-1000 MHz MEASURED DISTANCE: 10 M

Frequency (MHz)	Correction Factor (dB/m)	Reading Data (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)
45.48	13.3	16.9	30.2	40.0	-9.8
150.05	12.6	16.5	29.1	40.0	-10.9
168.03	11.5	15.8	27.3	40.0	-12.7
175.04	11.6	15.6	27.2	40.0	-12.8
178.99	11.7	19.8	31.5	40.0	-8.5
199.99	12.5	16.3	28.8	40.0	-11.2
215.99	13.2	19.7	32.9	40.0	-7.1
229.09	13.9	18.1	32.0	40.0	-8.0
343.65	17.5	23.0	40.5	47.0	-6.5
447.48	20.8	13.7	34.5	47.0	-12.5

1. Emission level (dBuV/m) = Correction Factor(dB/m)REMARKS: +Meter Reading (dBuV).

2. Correction Factor(dB/m) = Ant. Factor(dB/m)+Cable loss(dB)
3. The other emission levels were very low against the limit.

- 4. Margin value = Emission level Limit value



TEST DATA OF RADIATED EMISSION

EUT: **CPU BOARD** MODEL: **PCM-4896**

ANT. POLARITY: Vertical

DETECTOR FUNCTION: Quasi-peak 6 dB BANDWIDTH: 120 kHz

FREQUENCY RANGE: 30-1000 MHz MEASURED DISTANCE: 10 M

Frequency (MHz)	Correction Factor (dB/m)	Reading Data (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)
38.98	14.7	20.4	35.1	40.0	-4.9
45.49	12.5	16.7	29.2	40.0	-10.8
52.05	7.6	27.0	34.6	40.0	-5.4
77.95	7.9	23.2	31.1	40.0	-8.9
149.98	12.3	16.4	28.7	40.0	-11.3
168.03	11.4	19.2	30.6	40.0	-9.4
184.25	11.8	18.4	30.2	40.0	-9.8
186.13	11.8	16.3	28.1	40.0	-11.9
343.64	18.0	22.4	40.4	47.0	-6.6
447.30	21.2	10.5	31.7	47.0	-15.3

REMARKS: 1. Emission level (dBuV/m) = Correction Factor(dB/m)+Meter Reading (dBuV).

- 2. Correction Factor(dB/m) = Ant. Factor(dB/m)+Cable loss(dB)
 3. The other emission levels were very low against the limit.
 4. Margin value = Emission level Limit value



5. TEST RESULTS (IMMUNITY)

5.1 GENERAL DESCRIPTION

Generic Standard : EN 50082-2: 1995

Basic Standard and : EN 61000-4-2 (Electrostatic Discharge, ESD, 8kV air

Performance Criteria discharge, 4kV Contact discharge,

Performance Criterion B)

EN 61000-4-3 (Radio-Frequency Electromagnetic

Field Susceptibility Test, RS, 80-1000

MHz, 10V/m, 80% AM (1kHz), Performance Criterion A)

EN 61000-4-4 (Electrical Fast Transient/Burst, EFT,

Power line: 2kV, Signal line: 1kV,

Performance Criterion B)

EN 61000-4-6 (Conducted Radio Frequency

Disturbances Test, CS, 0.15-80 MHz, 10V/m, 80% AM, 1kHz, Performance

Criterion A)

EN 61000-4-8 (Power Frequency Magnetic Field Test,

50 Hz, 30A/m, Performance

Criterion A)

ENV 50204 (Radio-Frequency Electromagnetic

Field, Pulse modulated, 900+/-5 MHz,

10V/m, 50 % duty cycle, Rep. Frequency 200 Hz, Performance

REPORT NO.: CE88030401

Criterion A)

Input Voltage : 230 Vac, 50 Hz (to power of Industrial PC)

Temperature : 24 degree Humidity : 58 % Atmospheric Pressure : 998 mbar

5.2 PERFORMANCE CRITERIA DESCRIPTION

Criterion A - The apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a performance level

specified by the manufacturer, when the apparatus is used as intended.

Criterion B - The apparatus shall continue to operate as intended after the test. No

degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus

is used as intended.

Criterion C - Temporary loss of function is allowed, provided the function is self

recoverable or can be restored by the operation of the controls.

5.3 EUT OPERATION CONDITION

Industrial PC runs a test program to access FDD/HDD/MODEM/PRINTER sequentially and show the result on monitor screen.



5.4 TEST RESULT OF ELECTROSTATIC DISCHARGE (ESD)

Basic Standard : EN 61000-4-2 Generic Standard : EN 50082-2

Discharge Impedance : 330 ohm / 150 pF

Discharge Voltage : Air Discharge - 8 kV (Direct)

(Direct/Indirect) Contact Discharge - 4 kV (Indirect)

Polarity : Positive/Negative

Number of Discharge : Minimum 10 times at each test point

Discharge Mode : Single Discharge Discharge Period : 1 second minimum

Test Result		Remarks
Criterion A	PASS	Model: PCM-4896

OBSERVATION DESCRIPTION

Direct Application			Test R	esult
Discharge Level Polarity Test Point		Contact Discharge	Air Discharge	
(kV)	(+/-)			
8	+/-	1 ~ 5	NA	Note 1
4	+/-	1, 4, 5	Note 1	NA

Description of test point:

Metal case
 Junction of case
 Push button
 In/Out Port

5. Screws

Indirect Application			Test R	Result
Discharge Level	Polarity	Test Point	Horizontal Coupling	Vertical Coupling
(kV)	(+/-)			
4	+/-	1 ~ 4	Note 1	Note 1

Description of test point:

Front side
 Right side
 Left side
 Rear side

Description of test result:

Note 1: There was no change compared with initial operation during the test.



5.5 TEST RESULT OF RADIATED RADIO FREQUENCY DISTURBANCES (RS)

Basic Standard : EN 61000-4-3 Generic Standard : EN 50082-2

Frequency range : 80 MHz - 1000 MHz

Field strength : 10 V/m

Modulation : 1kHz Sine Wave, 80%, AM Modulation

Frequency step : 1 % of fundamental Polarity of Antenna : Horizontal and Vertical

Test distance : 3 m

Test Result		Remarks
Criterion A	PASS	Model: PCM-4896

Note: Four sides of EUT are verified separately.

OBSERVATION DESCRIPTION

There is no change compared with initial operation during the test.



5.6 TEST RESULT OF ELECTRICAL FAST TRANSIENT/BURST

(EFT/BURST)

Basic Standard EN 61000-4-4 Generic Standard : Test Voltage : EN 50082-2

Power Line - 2 kV (to power of Industrial PC) Test Voltage

Signal/Control Line – 1kV

Positive/Negative **Polarity**

Impulse Frequency : 5 kHz Tr / Tn 5/50 ns Burst Duration : 15 ms Burst Period 300 ms

Test Duration : Not less than 1 min.

Test Result		Remarks
Criterion A	PASS	Model: PCM-4896

OBSERVATION DESCRIPTION

Test Point	Polarity	Test Level (kV)	Result
L1	+/-	2	Note 1
L2	+/-	2	Note 1
GND	+/-	2	Note 1
Signal / Control	+/-	1	Note 1
Line			

Description of test result:

Note 1: There was no change compared to initial operation during the test.



5.7 TEST RESULT OF CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

Basic Standard : EN 61000-4-6 Generic Standard : EN 50082-2

Frequency range : 0.15 MHz - 80 MHz

Field strength : 10 V/m

Modulation : 1kHz Sine Wave, 80%, AM Modulation

Frequency step : 1 % of fundamental

Coupled cable : Power Mains, Unshielded

Coupling device : CDN-M3 (3 wires)

Test Result		Remarks
Criterion A	PASS	Model: PCM-4896

OBSERVATION DESCRIPTION

There is no change compared with initial operation during the test.



5.8 TEST RESULT OF POWER FREQUENCY MAGNETIC FIELD

Basic Standard : EN 61000-4-8 Generic Standard : EN 50082-2

Frequency range : 50 Hz
Field strength : 30 A/m
Observation Time : 1 minute

Inductance coil : Rectangular type, 1mx1m

Test Result		Remarks
Criterion A	PASS	Model: PCM-4896

OBSERVATION DESCRIPTION

There was no change compared with initial operation during the test.



5.9 TEST RESULT OF RADIO-FREQUENCY ELECTROMAGNETIC FIELD, PULSE MODULATED

Basic Standard : ENV 50204 Generic Standard : EN 50082-2 Frequency range : 900 +/- 5 MHz

Field strength : 10 V/m

Modulation : 200Hz, Square Wave, 50% Duty Cycle

Dewell Time : 30 second

Polarity of Antenna : Horizontal and Vertical

Test distance : 3 m

Test Result		Remarks
Criterion A	PASS	Model: PCM-4896

Note: Four sides of EUT are verified separately.

OBSERVATION DESCRIPTION

There is no change compared with initial operation during the test.



6. PHOTOGRAPHS OF THE TEST CONFIGURATION

CONDUCTED EMISSION TEST







RADIATED EMISSION TEST







ESD TEST







RS TEST (AM MODULATION AND PULSE MODULATION)





ADVANCE DATA TECHNOLOGY CORPORATION REPORT NO.: CE88030401



EFT TEST



EFT CLAMP TEST





CONDUCTED SUSCEPTIBILITY TEST



CONDUCTED SUSCEPTIBILITY CLAMP TEST





MAGNETIC TEST





7. APPENDIX - INFORMATION OF THE TESTING LABORATORY

<u>Information of the testing laboratory</u>

We, ADT Corp., is founded in 1988, to provide our best service in EMC and Safety consultation. Our laboratory is accredited by the following approval agencies according to ISO/IEC Guide 25 or EN 45001:

• USA FCC, UL, NVLAP

Germany
 TUV Rheinland

TUV Product Service

REPORT NO.: CE88030401

JapanVCCI

• New Zealand RFS

Norway
 NEMKO, DNV

• U.K. INCHCAPE, SGS

• R.O.C. BSMI

Enclosed please find some certificates of our laboratory obtained from approval agencies. If you have any comments, please feel free to contact us with the following:

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